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### Understanding [Embedded - Microprocessors](#)

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### Applications of [Embedded - Microprocessors](#)

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Product Status	Active
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	533MHz
Co-Processors/DSP	Security; SEC
RAM Controllers	DDR, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (2)
SATA	-
USB	-
Voltage - I/O	2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCPBGA (29x29)
Purchase URL	<a href="https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=mpc8541epxajd">https://www.e-xfl.com/pro/item?MUrl=&amp;PartUrl=mpc8541epxajd</a>

- Four global high resolution timers/counters that can generate interrupts
- Supports additional internal interrupt sources
- Supports fully nested interrupt delivery
- Interrupts can be routed to external pin for external processing
- Interrupts can be routed to the e500 core's standard or critical interrupt inputs
- Interrupt summary registers allow fast identification of interrupt source
- Two I<sup>2</sup>C controllers (one is contained within the CPM, the other is a stand-alone controller which is not part of the CPM)
  - Two-wire interface
  - Multiple master support
  - Master or slave I<sup>2</sup>C mode support
  - On-chip digital filtering rejects spikes on the bus
- Boot sequencer
  - Optionally loads configuration data from serial ROM at reset via the stand-alone I<sup>2</sup>C interface
  - Can be used to initialize configuration registers and/or memory
  - Supports extended I<sup>2</sup>C addressing mode
  - Data integrity checked with preamble signature and CRC
- DUART
  - Two 4-wire interfaces (RXD, TXD, RTS, CTS)
  - Programming model compatible with the original 16450 UART and the PC16550D
- Local bus controller (LBC)
  - Multiplexed 32-bit address and data operating at up to 166 MHz
  - Eight chip selects support eight external slaves
  - Up to eight-beat burst transfers
  - The 32-, 16-, and 8-bit port sizes are controlled by an on-chip memory controller
  - Three protocol engines available on a per chip select basis:
    - General purpose chip select machine (GPCM)
    - Three user programmable machines (UPMs)
    - Dedicated single data rate SDRAM controller
  - Parity support
  - Default boot ROM chip select with configurable bus width (8-, 16-, or 32-bit)
- Two Three-speed (10/100/1000)Ethernet controllers (TSECs)
  - Dual IEEE 802.3, 802.3u, 802.3x, 802.3z AC compliant controllers
  - Support for Ethernet physical interfaces:
    - 10/100/1000 Mbps IEEE 802.3 GMII
    - 10/100 Mbps IEEE 802.3 MII
    - 10 Mbps IEEE 802.3 MII

- Selectable hardware-enforced coherency
- Selectable clock source (SYSCLK or independent PCI\_CLK)
- Power management
  - Fully static 1.2-V CMOS design with 3.3- and 2.5-V I/O
  - Supports power save modes: doze, nap, and sleep
  - Employs dynamic power management
  - Selectable clock source (sysclk or independent PCI\_CLK)
- System performance monitor
  - Supports eight 32-bit counters that count the occurrence of selected events
  - Ability to count up to 512 counter specific events
  - Supports 64 reference events that can be counted on any of the 8 counters
  - Supports duration and quantity threshold counting
  - Burstiness feature that permits counting of burst events with a programmable time between bursts
  - Triggering and chaining capability
  - Ability to generate an interrupt on overflow
- System access port
  - Uses JTAG interface and a TAP controller to access entire system memory map
  - Supports 32-bit accesses to configuration registers
  - Supports cache-line burst accesses to main memory
  - Supports large block (4-Kbyte) uploads and downloads
  - Supports continuous bit streaming of entire block for fast upload and download
- IEEE Std 1149.1™-compatible, JTAG boundary scan
- 783 FC-PBGA package

## 2 Electrical Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the MPC8541E. The MPC8541E is currently targeted to these specifications. Some of these specifications are independent of the I/O cell, but are included for a more complete reference. These are not purely I/O buffer design specifications.

### 2.1 Overall DC Electrical Characteristics

This section covers the ratings, conditions, and other characteristics.

Figure 3 shows the undershoot and overshoot voltage of the PCI interface of the MPC8541E for the 3.3-V signals, respectively.

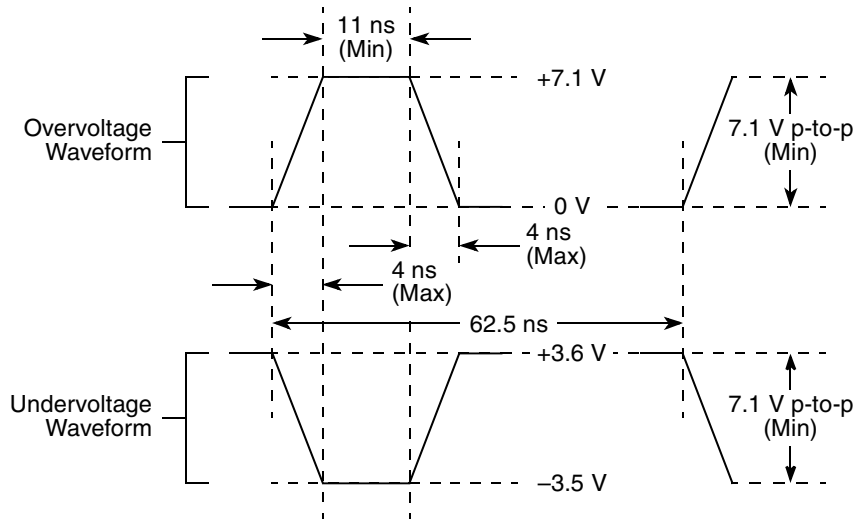


Figure 3. Maximum AC Waveforms on PCI interface for 3.3-V Signaling

### 2.1.4 Output Driver Characteristics

Table 3 provides information on the characteristics of the output driver strengths. The values are preliminary estimates.

Table 3. Output Drive Capability

Driver Type	Programmable Output Impedance ( $\Omega$ )	Supply Voltage	Notes
Local bus interface utilities signals	25	$OV_{DD} = 3.3\text{ V}$	1
	42 (default)		
PCI signals	25		2
	42 (default)		
DDR signal	20	$GV_{DD} = 2.5\text{ V}$	
TSEC/10/100 signals	42	$LV_{DD} = 2.5/3.3\text{ V}$	
DUART, system control, I2C, JTAG	42	$OV_{DD} = 3.3\text{ V}$	

**Notes:**

1. The drive strength of the local bus interface is determined by the configuration of the appropriate bits in PORIMPSR.
2. The drive strength of the PCI interface is determined by the setting of the `PCI_GNT1` signal at reset.

## 4 Clock Timing

### 4.1 System Clock Timing

Table 6 provides the system clock (SYSCLK) AC timing specifications for the MPC8541E.

**Table 6. SYSCLK AC Timing Specifications**

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
SYSCLK frequency	$f_{\text{SYSCLK}}$	—	—	166	MHz	1
SYSCLK cycle time	$t_{\text{SYSCLK}}$	6.0	—	—	ns	—
SYSCLK rise and fall time	$t_{\text{KH}}, t_{\text{KL}}$	0.6	1.0	1.2	ns	2
SYSCLK duty cycle	$t_{\text{KHK}}/t_{\text{SYSCLK}}$	40	—	60	%	3
SYSCLK jitter	—	—	—	+/- 150	ps	4, 5

**Notes:**

- Caution:** The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies.
- Rise and fall times for SYSCLK are measured at 0.6 and 2.7 V.
- Timing is guaranteed by design and characterization.
- This represents the total input jitter—short term and long term—and is guaranteed by design.
- For spread spectrum clocking, guidelines are  $\pm 1\%$  of the input frequency with a maximum of 60 kHz of modulation regardless of the input frequency.

### 4.2 TSEC Gigabit Reference Clock Timing

Table 7 provides the TSEC gigabit reference clock (EC\_GTX\_CLK125) AC timing specifications for the MPC8541E.

**Table 7. EC\_GTX\_CLK125 AC Timing Specifications**

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
EC_GTX_CLK125 frequency	$f_{\text{G125}}$	—	125	—	MHz	—
EC_GTX_CLK125 cycle time	$t_{\text{G125}}$	—	8	—	ns	—
EC_GTX_CLK125 rise time	$t_{\text{G125R}}$	—	—	1.0	ns	1
EC_GTX_CLK125 fall time	$t_{\text{G125F}}$	—	—	1.0	ns	1
EC_GTX_CLK125 duty cycle GMII, TBI RGMII, RTBI	$t_{\text{G125H}}/t_{\text{G125}}$	45 47	—	55 53	%	1, 2

**Notes:**

- Timing is guaranteed by design and characterization.
- EC\_GTX\_CLK125 is used to generate GTX clock for TSEC transmitter with 2% degradation. EC\_GTX\_CLK125 duty cycle can be loosened from 47/53% as long as PHY device can tolerate the duty cycle generated by GTX\_CLK of TSEC.

## 4.3 Real Time Clock Timing

Table 8 provides the real time clock (RTC) AC timing specifications.

**Table 8. RTC AC Timing Specifications**

Parameter/Condition	Symbol	Min	Typical	Max	Unit	Notes
RTC clock high time	$t_{RTCH}$	2 x $t_{CCB\_CLK}$	—	—	ns	—
RTC clock low time	$t_{RTCL}$	2 x $t_{CCB\_CLK}$	—	—	ns	—

## 5 RESET Initialization

This section describes the AC electrical specifications for the RESET initialization timing requirements of the MPC8541E. Table 9 provides the RESET initialization AC timing specifications.

**Table 9. RESET Initialization Timing Specifications**

Parameter/Condition	Min	Max	Unit	Notes
Required assertion time of $\overline{HRESET}$	100	—	$\mu$ s	—
Minimum assertion time for $\overline{SRESET}$	512	—	SYCLKs	1
PLL input setup time with stable SYCLK before HRESET negation	100	—	$\mu$ s	—
Input setup time for POR configs (other than PLL config) with respect to negation of $\overline{HRESET}$	4	—	SYCLKs	1
Input hold time for POR configs (including PLL config) with respect to negation of $\overline{HRESET}$	2	—	SYCLKs	1
Maximum valid-to-high impedance time for actively driven POR configs with respect to negation of $\overline{HRESET}$	—	5	SYCLKs	1

**Notes:**

1. SYCLK is identical to the PCI\_CLK signal and is the primary clock input for the MPC8541E. See the *MPC8555E PowerQUICC™ III Integrated Communications Processor Reference Manual* for more details.

Table 10 provides the PLL and DLL lock times.

**Table 10. PLL and DLL Lock Times**

Parameter/Condition	Min	Max	Unit	Notes
PLL lock times	—	100	$\mu$ s	—
DLL lock times	7680	122,880	CCB Clocks	1, 2

**Notes:**

1. DLL lock times are a function of the ratio between the output clock and the platform (or CCB) clock. A 2:1 ratio results in the minimum and an 8:1 ratio results in the maximum.
2. The CCB clock is determined by the SYCLK × platform PLL ratio.

Figure 6 provides the AC test load for the DDR bus.

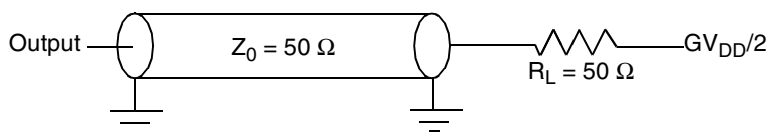


Figure 6. DDR AC Test Load

Table 15. DDR SDRAM Measurement Conditions

Symbol	DDR	Unit	Notes
$V_{TH}$	$MV_{REF} \pm 0.31 \text{ V}$	V	1
$V_{OUT}$	$0.5 \times GV_{DD}$	V	2

**Notes:**

1. Data input threshold measurement point.
2. Data output measurement point.

## 7 DUART

This section describes the DC and AC electrical specifications for the DUART interface of the MPC8541E.

### 7.1 DUART DC Electrical Characteristics

Table 16 provides the DC electrical characteristics for the DUART interface of the MPC8541E.

Table 16. DUART DC Electrical Characteristics

Parameter	Symbol	Test Condition	Min	Max	Unit
High-level input voltage	$V_{IH}$	$V_{OUT} \geq V_{OH} \text{ (min) or}$	2	$OV_{DD} + 0.3$	V
Low-level input voltage	$V_{IL}$	$V_{OUT} \leq V_{OL} \text{ (max)}$	-0.3	0.8	V
Input current	$I_{IN}$	$V_{IN}^1 = 0 \text{ V or } V_{IN} = V_{DD}$	—	$\pm 5$	$\mu\text{A}$
High-level output voltage	$V_{OH}$	$OV_{DD} = \text{min,}$ $I_{OH} = -100 \mu\text{A}$	$OV_{DD} - 0.2$	—	V
Low-level output voltage	$V_{OL}$	$OV_{DD} = \text{min, } I_{OL} = 100 \mu\text{A}$	—	0.2	V

**Note:**

1. Note that the symbol  $V_{IN}$ , in this case, represents the  $OV_{IN}$  symbol referenced in Table 1 and Table 2.

## 8.2.4 TBI AC Timing Specifications

This section describes the TBI transmit and receive AC timing specifications.

### 8.2.4.1 TBI Transmit AC Timing Specifications

Table 24 provides the MII transmit AC timing specifications.

**Table 24. TBI Transmit AC Timing Specifications**

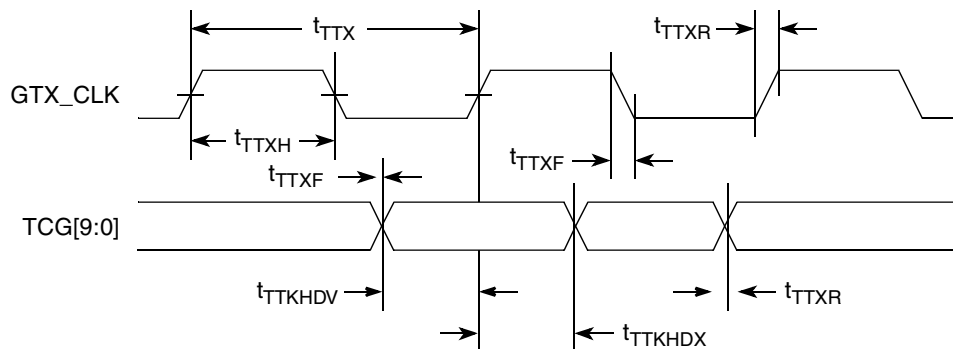
At recommended operating conditions with  $V_{DD}$  of  $3.3\text{ V} \pm 5\%$ .

Parameter/Condition	Symbol <sup>1</sup>	Min	Typ	Max	Unit
GTX_CLK clock period	$t_{TTX}$	—	8.0	—	ns
GTX_CLK duty cycle	$t_{TTXH}/t_{TTX}$	40	—	60	%
GMII data TCG[9:0], TX_ER, TX_EN setup time GTX_CLK going high	$t_{TTKHDV}$	2.0	—	—	ns
GMII data TCG[9:0], TX_ER, TX_EN hold time from GTX_CLK going high	$t_{TTKHDX}$	1.0	—	—	ns
GTX_CLK clock rise and fall time	$t_{TTXR}$ , $t_{TTXF}$ <sup>2,3</sup>	—	—	1.0	ns

**Notes:**

1. The symbols used for timing specifications herein follow the pattern of  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})}$  (reference)(state) for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})}$  (signal)(state) for outputs. For example,  $t_{TTKHDV}$  symbolizes the TBI transmit timing (TT) with respect to the time from  $t_{TTX}$  (K) going high (H) until the referenced data signals (D) reach the valid state (V) or setup time. Also,  $t_{TTKHDX}$  symbolizes the TBI transmit timing (TT) with respect to the time from  $t_{TTX}$  (K) going high (H) until the referenced data signals (D) reach the invalid state (X) or hold time. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of  $t_{TTX}$  represents the TBI (T) transmit (TX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
2. Signal timings are measured at 0.7 V and 1.9 V voltage levels.
3. Guaranteed by design.

Figure 12 shows the TBI transmit AC timing diagram.



**Figure 12. TBI Transmit AC Timing Diagram**



### 8.2.4.2 TBI Receive AC Timing Specifications

Table 25 provides the TBI receive AC timing specifications.

**Table 25. TBI Receive AC Timing Specifications**

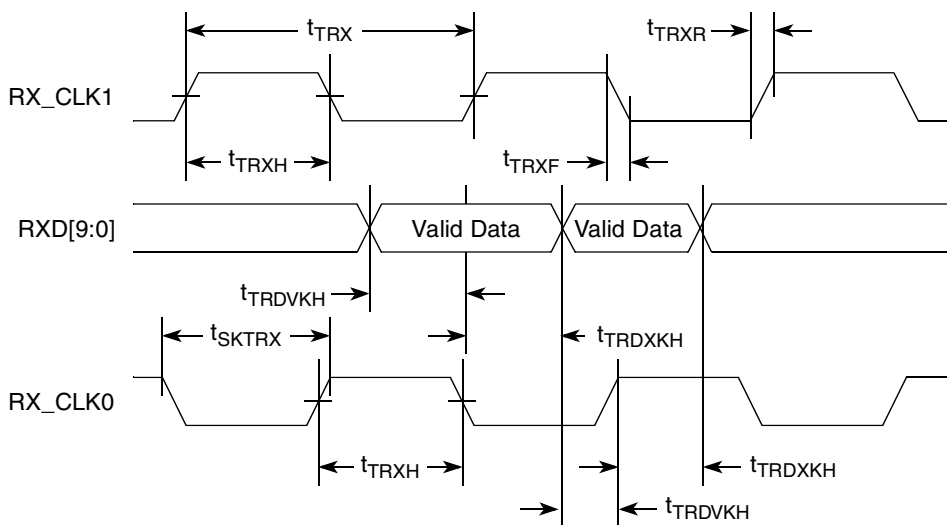
At recommended operating conditions with  $V_{DD}$  of 3.3 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Typ	Max	Unit
RX_CLK clock period	$t_{TRX}$		16.0		ns
RX_CLK skew	$t_{SKTRX}$	7.5	—	8.5	ns
RX_CLK duty cycle	$t_{TRXH}/t_{TRX}$	40	—	60	%
RCG[9:0] setup time to rising RX_CLK	$t_{TRDVKH}$	2.5	—	—	ns
RCG[9:0] hold time to rising RX_CLK	$t_{TRDXKH}$	1.5	—	—	ns
RX_CLK clock rise time and fall time	$t_{TRXR}, t_{TRXF}$ <sup>2,3</sup>	0.7	—	2.4	ns

**Note:**

- The symbols used for timing specifications herein follow the pattern of  $t_{(first\ two\ letters\ of\ functional\ block)(signal)(state)}$  (reference)(state) for inputs and  $t_{(first\ two\ letters\ of\ functional\ block)(reference)(state)(signal)(state)}$  for outputs. For example,  $t_{TRDVKH}$  symbolizes TBI receive timing (TR) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{TRX}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{TRDXKH}$  symbolizes TBI receive timing (TR) with respect to the time data input signals (D) went invalid (X) relative to the  $t_{TRX}$  clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For example, the subscript of  $t_{TRX}$  represents the TBI (T) receive (RX) clock. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall). For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (TRX).
- Guaranteed by design.

Figure 13 shows the TBI receive AC timing diagram.



**Figure 13. TBI Receive AC Timing Diagram**

## 8.2.5 RGMII and RTBI AC Timing Specifications

Table 26 presents the RGMII and RTBI AC timing specifications.

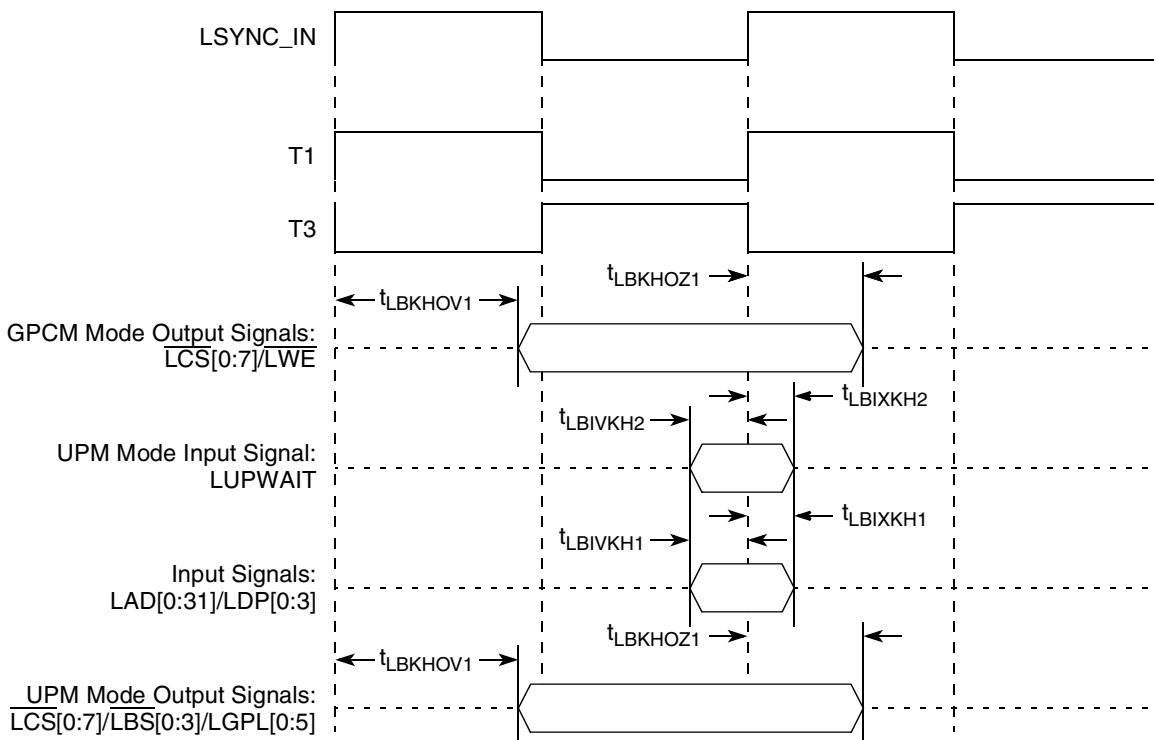
**Table 26. RGMII and RTBI AC Timing Specifications**

At recommended operating conditions with  $V_{DD}$  of 2.5 V  $\pm$  5%.

Parameter/Condition	Symbol <sup>1</sup>	Min	Typ	Max	Unit
Data to clock output skew (at transmitter)	$t_{SKRGT}^5$	-500	0	500	ps
Data to clock input skew (at receiver) <sup>2</sup>	$t_{SKRGT}$	1.0	—	2.8	ns
Clock cycle duration <sup>3</sup>	$t_{RGT}^6$	7.2	8.0	8.8	ns
Duty cycle for 1000Base-T <sup>4</sup>	$t_{RGTH}/t_{RGT}^6$	45	50	55	%
Duty cycle for 10BASE-T and 100BASE-TX <sup>3</sup>	$t_{RGTH}/t_{RGT}^6$	40	50	60	%
Rise and fall times	$t_{RGTR}^{6,7}$ , $t_{RGTF}^{6,7}$	—	—	0.75	ns

**Notes:**

- Note that, in general, the clock reference symbol representation for this section is based on the symbols RGT to represent RGMII and RTBI timing. For example, the subscript of  $t_{RGT}$  represents the TBI (T) receive (RX) clock. Note also that the notation for rise (R) and fall (F) times follows the clock symbol that is being represented. For symbols representing skews, the subscript is skew (SK) followed by the clock that is being skewed (RGT).
- The RGMII specification requires that PC board designer add 1.5 ns or greater in trace delay to the RX\_CLK in order to meet this specification. However, as stated above, this device functions with only 1.0 ns of delay.
- For 10 and 100 Mbps,  $t_{RGT}$  scales to 400 ns  $\pm$  40 ns and 40 ns  $\pm$  4 ns, respectively.
- Duty cycle may be stretched/shrunk during speed changes or while transitioning to a received packet's clock domains as long as the minimum duty cycle is not violated and stretching occurs for no more than three  $t_{RGT}$  of the lowest speed transitioned between.
- Guaranteed by characterization.
- Guaranteed by design.
- Signal timings are measured at 0.5 and 2.0 V voltage levels.



**Figure 19. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 2 (DLL Enabled)**

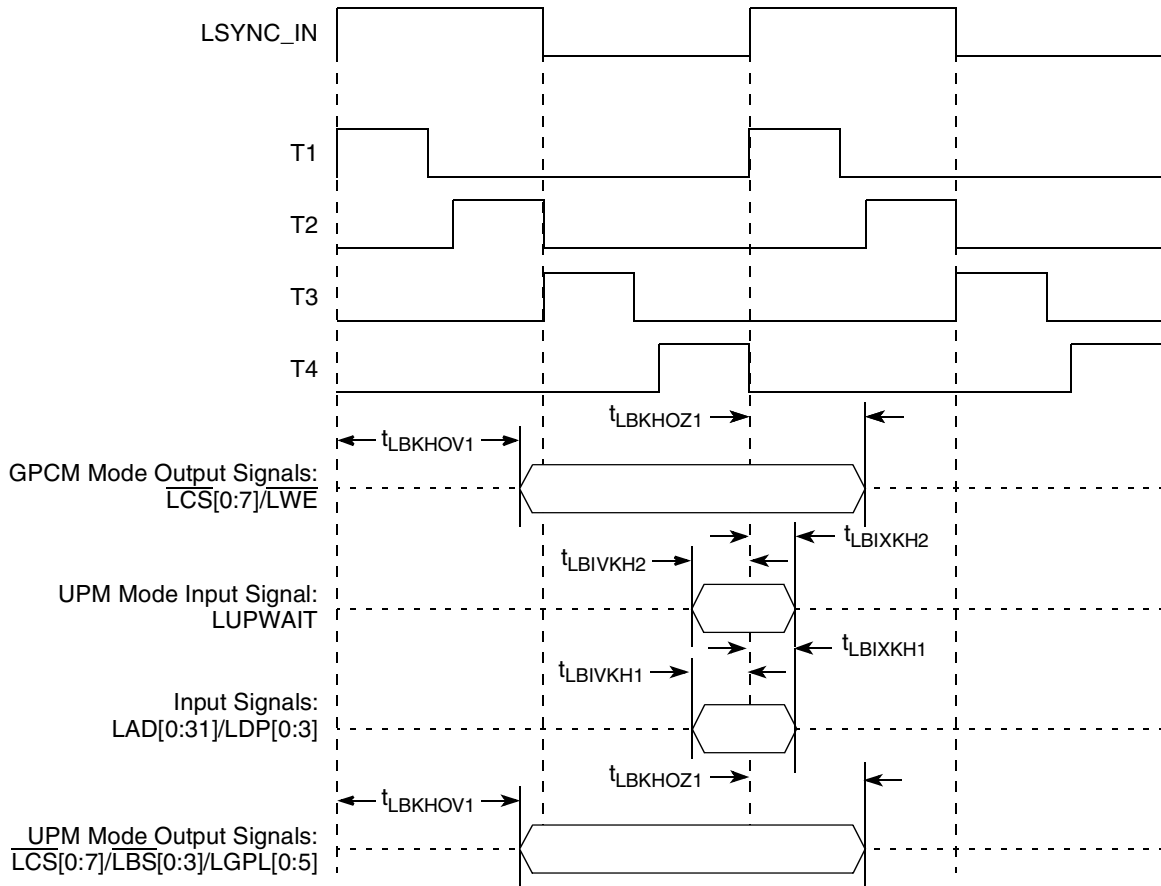


Figure 21. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 4 or 8 (DLL Enabled)

The following two tables are examples of I2C AC parameters at I2C clock value of 100k and 400k respectively.

**Table 36. CPM I2C Timing ( $f_{SCL}=100$  kHz)**

Characteristic	Expression	Frequency = 100 kHz		Unit
		Min	Max	
SCL clock frequency (slave)	$f_{SCL}$	—	100	kHz
SCL clock frequency (master)	$f_{SCL}$	—	100	kHz
Bus free time between transmissions	$t_{SDHDL}$	4.7	—	$\mu$ s
Low period of SCL	$t_{SCLCH}$	4.7	—	$\mu$ s
High period of SCL	$t_{SCHCL}$	4	—	$\mu$ s
Start condition setup time	$t_{SCHDL}$	2	—	$\mu$ s
Start condition hold time	$t_{SDLCL}$	3	—	$\mu$ s
Data hold time	$t_{SCLDX}$	2	—	$\mu$ s
Data setup time	$t_{SDVCH}$	3	—	$\mu$ s
SDA/SCL rise time	$t_{SRISE}$	—	1	$\mu$ s
SDA/SCL fall time (master)	$t_{SFALL}$	—	303	ns
Stop condition setup time	$t_{SCHDH}$	2	—	$\mu$ s

**Table 37. CPM I2C Timing ( $f_{SCL}=400$  kHz)**

Characteristic	Expression	Frequency = 400 kHz		Unit
		Min	Max	
SCL clock frequency (slave)	$f_{SCL}$	—	400	kHz
SCL clock frequency (master)	$f_{SCL}$	—	400	kHz
Bus free time between transmissions	$t_{SDHDL}$	1.2	—	$\mu$ s
Low period of SCL	$t_{SCLCH}$	1.2	—	$\mu$ s
High period of SCL	$t_{SCHCL}$	1	—	$\mu$ s
Start condition setup time	$t_{SCHDL}$	420	—	ns
Start condition hold time	$t_{SDLCL}$	630	—	ns
Data hold time	$t_{SCLDX}$	420	—	ns
Data setup time	$t_{SDVCH}$	630	—	ns
SDA/SCL rise time	$t_{SRISE}$	—	250	ns
SDA/SCL fall time	$t_{SFALL}$	—	75	ns
Stop condition setup time	$t_{SCHDH}$	420	—	ns

Figure 35 provides the test access port timing diagram.

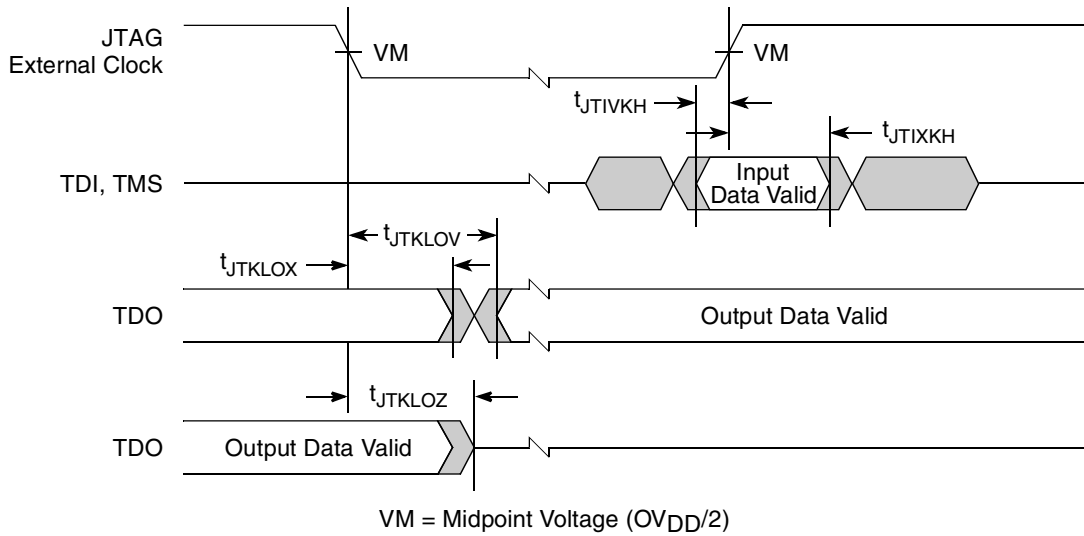


Figure 35. Test Access Port Timing Diagram

## 12 I<sup>2</sup>C

This section describes the DC and AC electrical characteristics for the I<sup>2</sup>C interface of the MPC8541E.

### 12.1 I<sup>2</sup>C DC Electrical Characteristics

Table 39 provides the DC electrical characteristics for the I<sup>2</sup>C interface of the MPC8541E.

Table 39. I<sup>2</sup>C DC Electrical Characteristics

At recommended operating conditions with  $OV_{DD}$  of  $3.3\text{ V} \pm 5\%$ .

Parameter	Symbol	Min	Max	Unit	Notes
Input high voltage level	$V_{IH}$	$0.7 \times OV_{DD}$	$OV_{DD} + 0.3$	V	—
Input low voltage level	$V_{IL}$	-0.3	$0.3 \times OV_{DD}$	V	—
Low level output voltage	$V_{OL}$	0	$0.2 \times OV_{DD}$	V	1
Output fall time from $V_{IH}(\text{min})$ to $V_{IL}(\text{max})$ with a bus capacitance from 10 to 400 pF	$t_{i2KLKV}$	$20 + 0.1 \times C_B$	250	ns	2
Pulse width of spikes which must be suppressed by the input filter	$t_{i2KHKL}$	0	50	ns	3
Input current each I/O pin (input voltage is between $0.1 \times OV_{DD}$ and $0.9 \times OV_{DD}(\text{max})$ )	$I_I$	-10	10	$\mu\text{A}$	4
Capacitance for each I/O pin	$C_I$	—	10	pF	—

**Notes:**

- Output voltage (open drain or open collector) condition = 3 mA sink current.
- $C_B$  = capacitance of one bus line in pF.
- Refer to the *MPC8555E PowerQUICC™ III Integrated Communications Processor Reference Manual* for information on the digital filter used.
- I/O pins obstruct the SDA and SCL lines if  $OV_{DD}$  is switched off.

## 12.2 I<sup>2</sup>C AC Electrical Specifications

Table 40 provides the AC timing parameters for the I<sup>2</sup>C interface of the MPC8541E.

**Table 40. I<sup>2</sup>C AC Electrical Specifications**

All values refer to  $V_{IH}$  (min) and  $V_{IL}$  (max) levels (see Table 39).

Parameter	Symbol <sup>1</sup>	Min	Max	Unit
SCL clock frequency	$f_{I2C}$	0	400	kHz
Low period of the SCL clock	$t_{I2CL}$ <sup>6</sup>	1.3	—	$\mu$ s
High period of the SCL clock	$t_{I2CH}$ <sup>6</sup>	0.6	—	$\mu$ s
Setup time for a repeated START condition	$t_{I2SVKH}$ <sup>6</sup>	0.6	—	$\mu$ s
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	$t_{I2SXKL}$ <sup>6</sup>	0.6	—	$\mu$ s
Data setup time	$t_{I2DVKH}$ <sup>6</sup>	100	—	ns
Data hold time: CBUS compatible masters I <sup>2</sup> C bus devices	$t_{I2DXKL}$	— 0 <sup>2</sup>	— 0.9 <sup>3</sup>	$\mu$ s
Rise time of both SDA and SCL signals	$t_{I2CR}$	$20 + 0.1 C_b$ <sup>4</sup>	300	ns
Fall time of both SDA and SCL signals	$t_{I2CF}$	$20 + 0.1 C_b$ <sup>4</sup>	300	ns
Set-up time for STOP condition	$t_{I2PVKH}$	0.6	—	$\mu$ s
Bus free time between a STOP and START condition	$t_{I2KHDX}$	1.3	—	$\mu$ s
Noise margin at the LOW level for each connected device (including hysteresis)	$V_{NL}$	$0.1 \times OV_{DD}$	—	V
Noise margin at the HIGH level for each connected device (including hysteresis)	$V_{NH}$	$0.2 \times OV_{DD}$	—	V

### Notes:

- The symbols used for timing specifications herein follow the pattern of  $t_{(\text{first two letters of functional block})(\text{signal})(\text{state})(\text{reference})(\text{state})}$  for inputs and  $t_{(\text{first two letters of functional block})(\text{reference})(\text{state})(\text{signal})(\text{state})}$  for outputs. For example,  $t_{I2DVKH}$  symbolizes I<sup>2</sup>C timing (I2) with respect to the time data input signals (D) reach the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time. Also,  $t_{I2SXKL}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the start condition (S) went invalid (X) relative to the  $t_{I2C}$  clock reference (K) going to the low (L) state or hold time. Also,  $t_{I2PVKH}$  symbolizes I<sup>2</sup>C timing (I2) for the time that the data with respect to the stop condition (P) reaching the valid state (V) relative to the  $t_{I2C}$  clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
- MPC8541E provides a hold time of at least 300 ns for the SDA signal (referred to the  $V_{IHmin}$  of the SCL signal) to bridge the undefined region of the falling edge of SCL.
- The maximum  $t_{I2DVKH}$  has only to be met if the device does not stretch the LOW period ( $t_{I2CL}$ ) of the SCL signal.
- $C_B$  = capacitance of one bus line in pF.
- Guaranteed by design.

Table 43. MPC8541E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TSEC2_CRS	D9	I	LV <sub>DD</sub>	—
TSEC2_COL	F8	I	LV <sub>DD</sub>	—
TSEC2_RXD[7:0]	F9, E9, C9, B9, A9, H9, G10, F10	I	LV <sub>DD</sub>	—
TSEC2_RX_DV	H8	I	LV <sub>DD</sub>	—
TSEC2_RX_ER	A8	I	LV <sub>DD</sub>	—
TSEC2_RX_CLK	E10	I	LV <sub>DD</sub>	—
<b>DUART</b>				
UART_CTS[0,1]	Y2, Y3	I	OV <sub>DD</sub>	—
UART_RTS[0,1]	Y1, AD1	O	OV <sub>DD</sub>	—
UART_SIN[0,1]	P11, AD5	I	OV <sub>DD</sub>	—
UART_SOUT[0,1]	N6, AD2	O	OV <sub>DD</sub>	—
<b>I<sup>2</sup>C interface</b>				
IIC_SDA	AH22	I/O	OV <sub>DD</sub>	4, 19
IIC_SCL	AH23	I/O	OV <sub>DD</sub>	4, 19
<b>System Control</b>				
HRESET	AH16	I	OV <sub>DD</sub>	—
HRESET_REQ	AG20	O	OV <sub>DD</sub>	18
SRESET	AF20	I	OV <sub>DD</sub>	—
CKSTP_IN	M11	I	OV <sub>DD</sub>	—
CKSTP_OUT	G1	O	OV <sub>DD</sub>	2, 4
<b>Debug</b>				
TRIG_IN	N12	I	OV <sub>DD</sub>	—
TRIG_OUT/READY	G2	O	OV <sub>DD</sub>	6, 9, 18
MSRCID[0:1]	J9, G3	O	OV <sub>DD</sub>	5, 6, 9
MSRCID[2:3]	F3, F5	O	OV <sub>DD</sub>	6
MSRCID4	F2	O	OV <sub>DD</sub>	6
MDVAL	F4	O	OV <sub>DD</sub>	6
<b>Clock</b>				
SYSCLK	AH21	I	OV <sub>DD</sub>	—
RTC	AB23	I	OV <sub>DD</sub>	—
CLK_OUT	AF22	O	OV <sub>DD</sub>	—



### 15.3 e500 Core PLL Ratio

Table 47 describes the clock ratio between the e500 core complex bus (CCB) and the e500 core clock. This ratio is determined by the binary value of LALE and LGPL2 at power up, as shown in Table 47.

**Table 47. e500 Core to CCB Ratio**

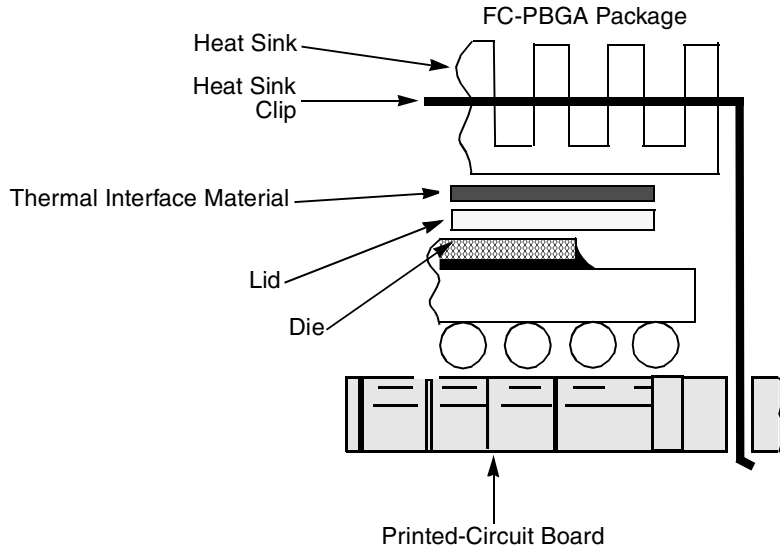
Binary Value of LALE, LGPL2 Signals	Ratio Description
00	2:1 e500 core:CCB
01	5:2 e500 core:CCB
10	3:1 e500 core:CCB
11	7:2 e500 core:CCB

### 15.4 Frequency Options

Table 48 shows the expected frequency values for the platform frequency when using a CCB to SYSCLK ratio in comparison to the memory bus speed.

**Table 48. Frequency Options with Respect to Memory Bus Speeds**

CCB to SYSCLK Ratio	SYSCLK (MHz)								
	17	25	33	42	67	83	100	111	133
	Platform/CCB Frequency (MHz)								
2							200	222	267
3					200	250	300	333	
4					267	333			
5				208	333				
6			200	250					
8		200	267	333					
9		225	300						
10		250	333						
12	200	300							
16	267								

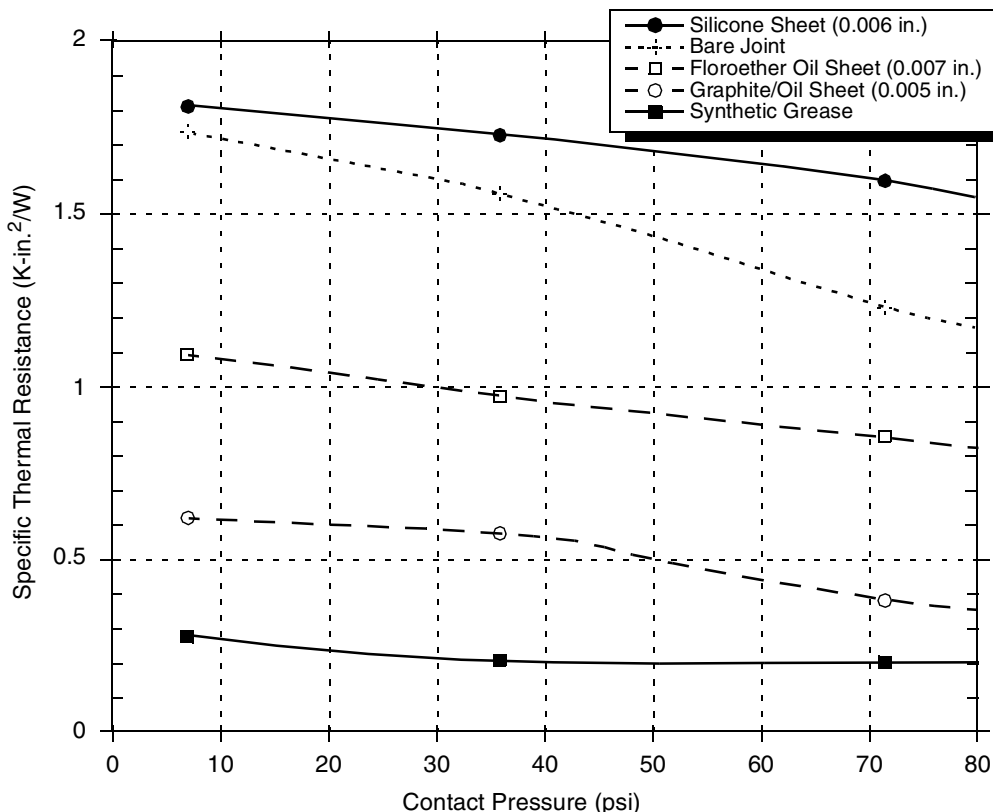


**Figure 42. Package Exploded Cross-Sectional View with Several Heat Sink Options**

The system board designer can choose between several types of heat sinks to place on the MPC8541E. There are several commercially-available heat sinks from the following vendors:

- |  |              |
|--|--------------|
| Aavid Thermalloy<br>80 Commercial St.<br>Concord, NH 03301<br>Internet: <a href="http://www.aavidthermalloy.com">www.aavidthermalloy.com</a>                               | 603-224-9988 |
| Alpha Novatech<br>473 Sapena Ct. #15<br>Santa Clara, CA 95054<br>Internet: <a href="http://www.alphanovatech.com">www.alphanovatech.com</a>                                | 408-749-7601 |
| International Electronic Research Corporation (IERC)<br>413 North Moss St.<br>Burbank, CA 91502<br>Internet: <a href="http://www.ctscorp.com">www.ctscorp.com</a>          | 818-842-7277 |
| Millennium Electronics (MEI)<br>Loroco Sites<br>671 East Brokaw Road<br>San Jose, CA 95112<br>Internet: <a href="http://www.mei-millennium.com">www.mei-millennium.com</a> | 408-436-8770 |
| Tyco Electronics<br>Chip Coolers™<br>P.O. Box 3668<br>Harrisburg, PA 17105-3668<br>Internet: <a href="http://www.chipcoolers.com">www.chipcoolers.com</a>                  | 800-522-6752 |
| Wakefield Engineering<br>33 Bridge St.<br>Pelham, NH 03076<br>Internet: <a href="http://www.wakefield.com">www.wakefield.com</a>   | 603-635-5102 |

the heat sink should be slowly removed. Heating the heat sink to 40–50°C with an air gun can soften the interface material and make the removal easier. The use of an adhesive for heat sink attach is not recommended.

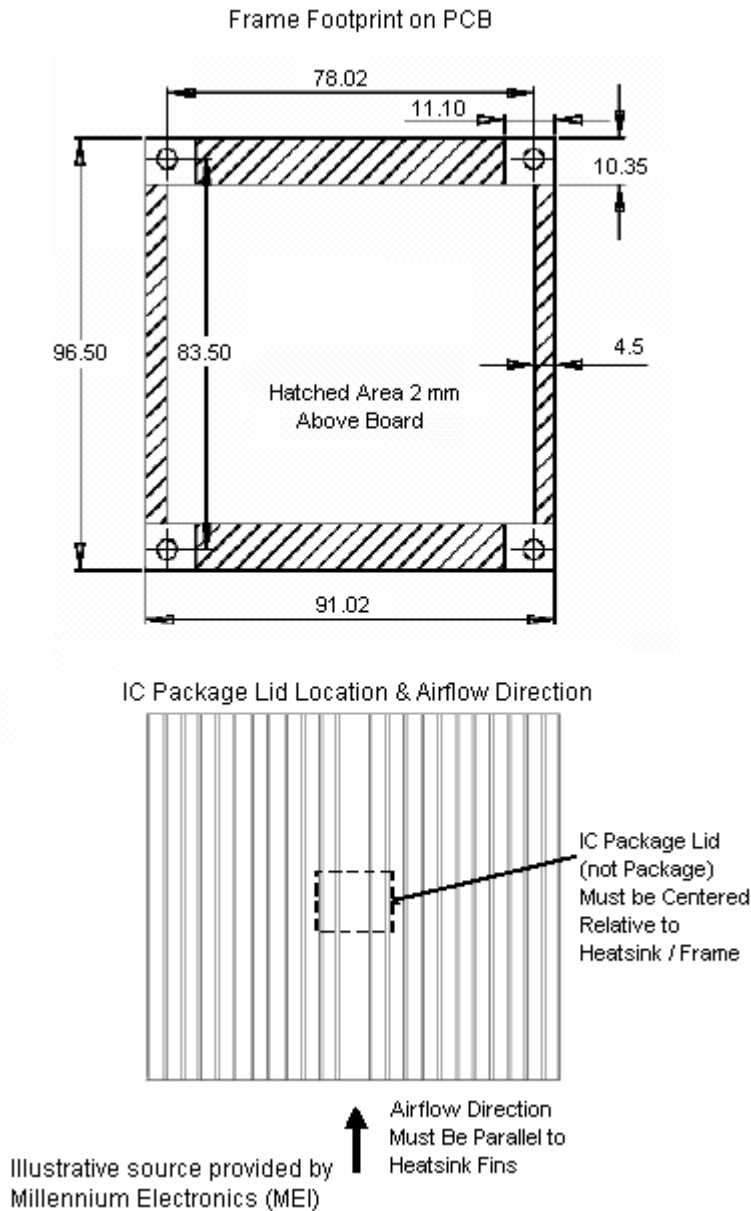


**Figure 45. Thermal Performance of Select Thermal Interface Materials**

The system board designer can choose between several types of thermal interface. There are several commercially-available thermal interfaces provided by the following vendors:

Chomerics, Inc. 77 Dragon Ct. Woburn, MA 01888-4014 Internet: <a href="http://www.chomerics.com">www.chomerics.com</a>	781-935-4850
Dow-Corning Corporation Dow-Corning Electronic Materials 2200 W. Salzburg Rd. Midland, MI 48686-0997 Internet: <a href="http://www.dowcorning.com">www.dowcorning.com</a>	800-248-2481
Shin-Etsu MicroSi, Inc. 10028 S. 51st St. Phoenix, AZ 85044 Internet: <a href="http://www.microsi.com">www.microsi.com</a>	888-642-7674
The Bergquist Company 18930 West 78 <sup>th</sup> St.	800-347-4572

The spring mounting should be designed to apply the force only directly above the die. By localizing the force, rocking of the heat sink is minimized. One suggested mounting method attaches a plastic fence to the board to provide the structure on which the heat sink spring clips. The plastic fence also provides the opportunity to minimize the holes in the printed-circuit board and to locate them at the corners of the package. Figure 47 and provide exploded views of the plastic fence, heat sink, and spring clip.



**Figure 47. Exploded Views (1) of a Heat Sink Attachment using a Plastic Fence**

# 18 Document Revision History

Table 51 provides a revision history for this hardware specification.

**Table 51. Document Revision History**

Rev. No.	Date	Substantive Change(s)
4.2	1/2008	Added "Note: Rise/Fall Time on CPM Input Pins" and following note text to <a href="#">Section 10.2, "CPM AC Timing Specifications."</a>
4.1	07/2007	Inserted <a href="#">Figure 3</a> , "Maximum AC Waveforms on PCI interface for 3.3-V Signaling."
4	12/2006	Updated <a href="#">Section 2.1.2, "Power Sequencing."</a> Updated back page information.
3.2	11/2006	Updated <a href="#">Section 2.1.2, "Power Sequencing."</a> Replaced <a href="#">Section 17.8, "JTAG Configuration Signals."</a>
3.1	10/2005	<a href="#">Table 4</a> : Added footnote 2 about junction temperature. <a href="#">Table 4</a> : Added max. power values for 1000 MHz core frequency. Removed <a href="#">Figure 3</a> , "Maximum AC Waveforms on PCI Interface for 3.3-V Signaling." <a href="#">Table 30</a> : Modified note to $t_{LBKSKEW}$ from 8 to 9 <a href="#">Table 30</a> : Changed $t_{LBKHOZ1}$ and $t_{LBKHOV2}$ values. <a href="#">Table 30</a> : Added note 3 to $t_{LBKHOV1}$ . <a href="#">Table 30</a> and <a href="#">Table 31</a> : Modified note 3. <a href="#">Table 31</a> : Added note 3 to $t_{LBKLOV1}$ . <a href="#">Table 31</a> : Modified values for $t_{LBKHKT}$ , $t_{LBKLOV1}$ , $t_{LBKLOV2}$ , $t_{LBKLOV3}$ , $t_{LBKLOZ1}$ , and $t_{LBKLOZ2}$ . <a href="#">Figure 21</a> : Changed Input Signals: LAD[0:31]/LDP[0:3]. <a href="#">Table 43</a> : Modified note for signal CLK_OUT. <a href="#">Table 43</a> : PCI1_CLK and PCI2_CLK changed from I/O to I. <a href="#">Table 52</a> : Added column for Encryption Acceleration.
3	8/29/2005	<a href="#">Table 4</a> : Modified max. power values. <a href="#">Table 43</a> : Modified notes for signals TSEC1_TXD[3:0], TSEC2_TXD[3:0], TRIG_OUT/READY, MSRCID4, and MDVAL.
2	8/2005	Previous revision's history listed incorrect cross references. <a href="#">Table 2</a> is now correctly listed as <a href="#">Table 27</a> and <a href="#">Table 31</a> is now listed as <a href="#">Table 31</a> . <a href="#">Table 7</a> : Added note 2. <a href="#">Table 14</a> : Modified min and max values for $t_{DDKHMP}$
1	6/2005	<a href="#">Table 27</a> : Changed $V_{dd}$ to $O_{Vdd}$ for the supply voltage Ethernet management interface. <a href="#">Table 4</a> : Modified footnote 4 and changed typical power for the 1000MHz core frequency. <a href="#">Table 31</a> : Corrected symbols for body rows 9–15, effectively changing them from a high state to a low state.
0	6/2005	Initial Release.